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HEARING AID COMPATIBILITY

Applicant Name:

Samsung Electronics Co., Ltd. 129, Samsung-ro, Maetan dong, Yeongtong-gu, Suwon-si Gyeonggi-do 16677, Korea

Date of Testing: 12/20/2021 - 12/21/2021 Test Site/Location: PCTEST, Columbia, MD, USA Test Report Serial No.: 1M2112280172-04.A3L Date of Issue: 2/16/2022

FCC ID:

A3LSMF711U1

APPLICANT:

SAMSUNG ELECTRONICS CO., LTD.

Scope of Test: Application Type: FCC Rule Part(s): HAC Standard:

DUT Type: Model: Additional Model(s): Test Device Serial No.: Class II Permissive Change(s): Audio Band Magnetic Testing (T-Coil) Class II Permissive Change CFR §20.19(b) ANSI C63.19-2011 285076 D01 HAC Guidance v05 285076 D02 T-Coil testing for CMRS IP v03 Portable Handset SM-F711U SM-F711U1 *Pre-Production Sample* [S/N: 0908M] *See FCC Change Document*

C63.19-2011 HAC Category: 7

T4 (SIGNAL TO NOISE CATEGORY, n48 only)

This report and category pertain only to NR n48 supported by this wireless portable device. The overall category rating of the device is determined by the lowest rating obtained over all air interfaces supported by the device. This wireless portable device has been shown to be hearing-aid compatible under the above rated category, specified in ANSI/IEEE Std. C63.19-2011 and has been tested in accordance with the specified measurement procedures. Test results reported herein relate only to the item(s) tested. Hearing-Aid Compatibility is based on the assumption that all production units will be designed electrically identical to the device tested in this report. North American Bands only.

I attest to the accuracy of data. All measurements reported herein were performed by me or were made under my supervision and are correct to the best of my knowledge and belief. I assume full responsibility for the completeness of these measurements and vouch for the qualifications of all persons taking them.

Randy Ortanez President



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1. INTRODUCTION

On July 10, 2003, the Federal Communications Commission (FCC) adopted new rules requiring wireless manufacturers and service providers to provide digital wireless phones that are compatible with hearing aids. The FCC has modified the exemption for wireless phones under the Hearing Aid Compatibility Act of 1998 (HAC Act) in WT Docket 01-309 RM-8658¹ to extend the benefits of wireless telecommunications to individuals with hearing disabilities. These benefits encompass business, social and emergency communications, which increase the value of the wireless network for everyone. An estimated more than 10% of the population in the United States show signs of hearing impairment and of that fraction, almost 80% use hearing aids. Approximately 500 million people worldwide and 30 million people in the United States suffer from hearing loss.

Compatibility Tests Involved:

The standard calls for wireless communications devices to be measured for:

- RF Electric-field emissions
- T-coil mode, magnetic-signal strength in the audio band
- T-coil mode, magnetic-signal frequency response through the audio band
- T-coil mode, magnetic-signal and noise articulation index

The hearing aid must be measured for:

- RF immunity in microphone mode
- RF immunity in T-coil mode

In the following tests and results, this report includes the evaluation for a wireless communications device.



Figure 1-1 Hearing Aid in-vitu

¹ FCC Rule & Order, WT Docket 01-309 RM-8658

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2. DUT DESCRIPTION



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Applicant:	Samsung Electronics Co., Ltd.
	129, Samsung-ro, Maetan dong,
	Yeongtong-gu, Suwon-si
	Gyeonggi-do 16677, Korea
Model:	SM-F711U
Additional Model(s):	SM-F711U1
Serial Number:	0908M
HW Version:	REV1.0
SW Version:	F711SQU0AUD5
Antenna:	Internal Antenna
DUT Type:	Portable Handset

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Air-Interface	Band (MHz)	Type Transport	HAC Tested	Simultaneous But Not Tested	Name of Voice Service	Audio Codec Evaluated
	835	vo	No ¹	Yes: WIFI or BT	CMRS Voice	EVRC
CDMA	1900	_				
	EvDO	VD	No ¹	Yes: WIFI or BT	Google Duo ²	OPUS
	850	vo	No ¹	Yes: WIFI or BT	CMRS Voice	EFR
GSM	1900					
	GPRS/EDGE	VD	No ¹	Yes: WIFI or BT	Google Duo ²	OPUS
	850		. 1			
UMTS	1700	VD	No ¹	Yes: WIFI or BT	CMRS Voice	NB AMR, WB AMR
	1900	1/5	. 1	V M//5/ DT	Casala Dura?	OPUS
	HSPA	VD	No ¹	Yes: WIFI or BT	Google Duo ²	OPUS
	680 (B71)					
	700 (B12)					
	780 (B13)					
	790 (B14) 850 (B5)					
	850 (B26)					
LTE (FDD)		VD	No ¹	Yes: NR, WIFI or BT	VoLTE, Google Duo ²	VoLTE: NB AMR, WB AMR, EV Google Duo: OPUS
	1700 (B4) 1700 (B66)					
	1900 (B88)					
	1900 (B2) 1900 (B25)					
	2300 (B23)					
	2500 (B30)					
	2600 (B41)					
LTE (TDD)	2600 (B41)	VD	No ¹	Yes: NR, WIFI or BT	VoLTE, Google Duo ²	VoLTE: NB AMR, WB AMR, EVS
112 (100)	3600 (B48)		NO		VOLTE, GOOGIE Duo	Google Duo: OPUS
	680 (n71)					
	700 (n12)					
	850 (n5)					
NR (FDD)	1700 (n66)	VD	No ¹	Yes: LTE, WIFI or BT	Google Duo ²	OPUS
、 <i>,</i>	1900 (n2)			··· , ···		
	1900 (n25)					
	2300 (n30)					
	2600 (n41)		1			
	3500 (n77, DoD)		No ¹			
	3600 (n48)		Yes ³			
NR (TDD)	3700 (n77)	VD		Yes: LTE, WIFI or BT	Google Duo ²	OPUS
	28000 (n261)		No ¹			
	39000 (n260)					
	2450					
	5200 (U-NII 1)					
WIFI	5300 (U-NII 2A)	VD	No ¹	Yes: CDMA, GSM, UMTS, LTE, or NR	VoWIFI ² , Google Duo ²	VoWIFI: NB AMR, WB AMR, EV Google Duo: OPUS
	5500 (U-NII 2C)					Google Duo. OF03
	5800 (U-NII 3)					
BT	2450	DT	No	Yes: CDMA, GSM, UMTS, LTE, or NR	N/A	N/A
Type Transport			Notes:			
VO = Voice Onl DT = Digital Da	y ta - Not intended for	Voice Services		ertains to NR n48 only. For full data, please refe vel is -20dBm0 in accordance with FCC KDB 285		//210/290086-02.A3L)
	or IP Voice over Dat			uated using an interim procedure outlined in Sec		

Table 2-1 A3LSMF711U1 HAC Air Interfaces

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3. ANSI C63.19-2011 PERFORMANCE CATEGORIES

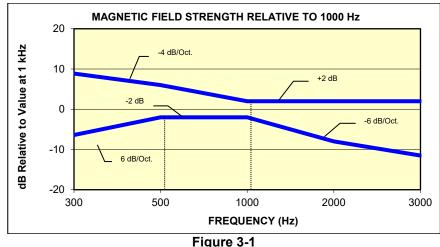
I. MAGNETIC COUPLING

Axial and Radial Field Intensity

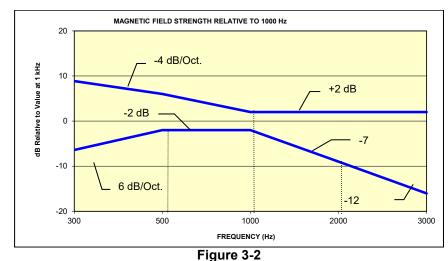
All orientations of the magnetic field, in the axial and radial position along the measurement plane shall be \geq -18 dB(A/m) at 1 kHz in a 1/3 octave band filter per §8.3.1.

Frequency Response

The frequency response of the axial component of the magnetic field shall follow the response curve specified in EIA RS-504-1983, over the frequency range 300 Hz - 3000 Hz per §8.3.2.



Magnetic field frequency response for Wireless Devices with an axial field ≤-15 dB(A/m) at 1 kHz



Magnetic Field frequency response for wireless devices with an axial field that exceeds -15 dB(A/m) at 1 kHz

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Signal Quality

The table below provides the signal quality requirement for the intended audio magnetic signal from a wireless device. Only the RF immunity of the hearing aid is measured in T-coil mode. It is assumed that a hearing aid can have no immunity to an interference signal in the audio band, which is the intended reception band for this mode. The only criterion that can be measured is the RF immunity in T-coil mode. This is measured using the same procedure as the audio coupling mode at the same levels.

The signal quality of the axial and radial components of the magnetic field was used to determine the T-coil mode category.

Cotogomy	Telephone RF Parameters		
Category	Wireless Device Signal Quality [(Signal + Noise)-to-noise ratio in dB]		
T1	0 to 10 dB		
T2	10 to 20 dB		
Т3	20 to 30 dB		
T4	> 30 dB		
Table 3-1 Magnetic Coupling Parameters			

Note: The FCC limit for SNNR is 20dB and the test data margins will indicate a margin from the FCC limit for compliance.

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4. METHOD OF MEASUREMENT

I. Test Setup

The equipment was connected as shown in an RF-shielded chamber:

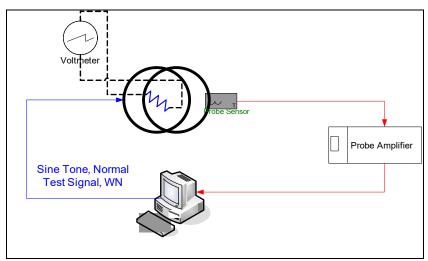
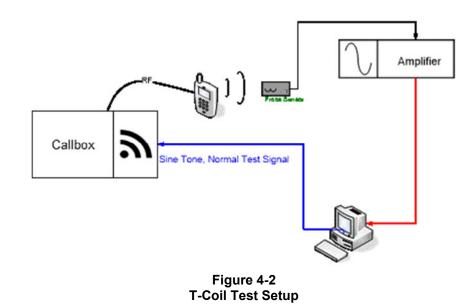


Figure 4-1 Validation Setup with Helmholtz Coil



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II. Scanning Mechanism

Manufacturer:	TEM
Accuracy:	± 0.83 cm/meter
Minimum Step Size:	0.1 mm
Maximum speed	6.1 cm/sec
Line Voltage:	115 VAC
Line Frequency:	60 Hz
Material Composite:	Delrin (Acetal)
Data Control:	Parallel Port
Dynamic Range (X-Y-Z):	45 x 31.75 x 47 cm
Dimensions:	36" x 25" x 38"
Operating Area:	36" x 49" x 55"
Reflections:	< -20 dB (in anechoic chamber)

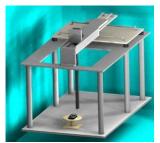


Figure 4-3 RF Near-Field Scanner

III. 3GPP2 Normal Test Signal (Speech)

Manufacturer:	3GPP2 (TIA 1042 §3.3.1)	
	Modified-IRS weighted, multi-talker speech signal, 4 Male and 4	
Stimulus Type:	Female speakers (alternating)	
Single Sample Duration:	51.62 seconds	
Activity Level:	77.4%	
-		

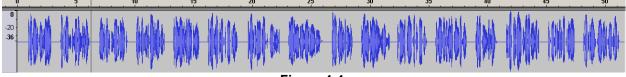
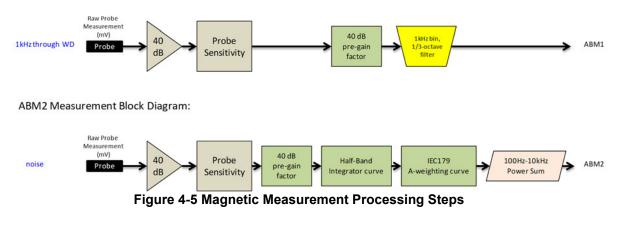


Figure 4-4 Temporal Characteristic of Normal Test Signal

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ABM1 Measurement Block Diagram:



IV. Test Procedure

- 1. Ambient Noise Check per C63.19 §7.3.1
 - Ambient interference was monitored using a Real-Time Analyzer between 100-10,000 Hz with 1/3 octave filtering.
 - b. "A-weighting" and Half-Band Integration was applied to the measurements.
 - c. Since this measurement was measured in the same method as ABM2 measurements, this level was verified to be more than 10 dB below the lowest measurement signal (which is the highest ABM2 measurement for a T4 WD). Therefore the maximum noise level for a T4 WD with an ABM1 = -18 dBA/m is:

- 2. Measurement System Validation (See Figure 4-1)
 - a. The measurement system including the probe, pre-amplifier and acquisition system were validated as an entire system to ensure the reliability of test measurements.
 - b. ABM1 Validation

The magnetic field at the center of the Helmholtz coil is given by the equation (per C63.19 Annex D.10.1):

$$H_{c} = \frac{NI}{r\sqrt{1.25^{3}}} = \frac{N(\frac{V}{R})}{r\sqrt{1.25^{3}}}$$

Where H_c = magnetic field strength in amperes per meter N = number of turns per coil

For Helmholtz Coil SN: SBI 1052, N=20; r=0.13m; R=10.193Ω and using V=29mV:

$$H_{c} = \frac{20 \cdot (\frac{0.029}{10.193})}{0.13 \cdot \sqrt{1.25^{3}}} = 0.316 A / m \approx -10 dB (A / m)$$

Therefore a pure tone of 1kHz was applied into the coils such that 29mV was observed across the resistor. The voltmeter used for measurement was verified to be capable of measurements in the audio band range. This theoretically generates an expected field of -10 dB(A/m) in the center of the Helmholtz coil which was used to validate the probe measurement at -10dB(A/m). This was verified to be within \pm 0.5 dB of the -10dB(A/m) value (see Page 20).

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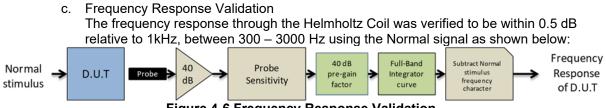


Figure 4-6 Frequency Response Validation

d. ABM2 Measurement Validation

WD noise measurements are filtered with A-weighting and Half-Band Integration over a frequency range of 100Hz - 10kHz to process ABM2 measurements. Below is the verification of the system processing A-weighting and Half-Band integration between system input to output within 0.5 dB of the theoretical result:

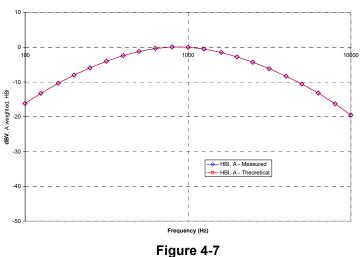
ABM2 Frequency Response Validation				
	HBI, A -	HBI, A -		
f (Hz)	Measured	Theoretical	dB Var.	
	(dB re 1kHz)	(dB re 1kHz)		
100	-16.180	-16.170	-0.010	
125	-13.257	-13.250	-0.007	
160	-10.347	-10.340	-0.007	
200	-8.017	-8.010	-0.007	
250	-5.925	-5.920	-0.005	
315	-4.045	-4.040	-0.005	
400	-2.405	-2.400	-0.005	
500	-1.212	-1.210	-0.002	
630	-0.349	-0.350	0.001	
800	0.071	0.070	0.001	
1000	0.000	0.000	0.000	
1250	-0.503	-0.500	-0.003	
1600	-1.513	-1.510	-0.003	
2000	-2.778	-2.780	0.002	
2500	-4.316	-4.320	0.004	
3150	-6.166	-6.170	0.004	
4000	-8.322	-8.330	0.008	
5000	-10.573	-10.590	0.017	
6300	-13.178	-13.200	0.022	
8000	-16.241	-16.270	0.029	
10000	-19.495	-19.520	0.025	

Table 4-1 - 12 -1 - 42 - ----

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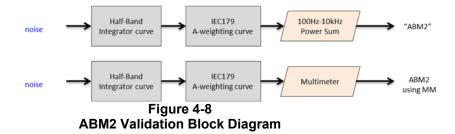
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ABM2 Frequency Response Validation (LISTEN)



ABM2 Frequency Response Validation

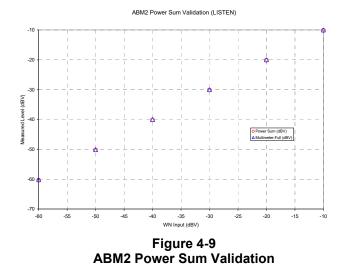
The ABM2 result is a power sum from 100Hz to 10kHz with half-band integration and Aweighting. To verify the power sum measurement, a power sum over the full band was measured and verified to track with the source level (See Figure 4-8). Therefore the setup in this step was used to verify the power sum post-processing for ABM2 measurements. See below block diagram:



The power summed output results for a known input were compared to the multi-meter results to verify any deviation in the post-processing implemented with the power-sum.

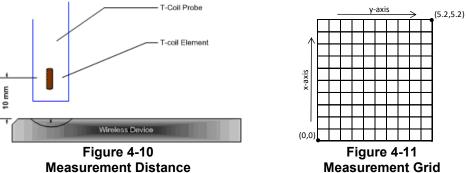
Table 4-2 ABM2 Power Sum Validation					
WN Input (dBV)	Power Sum (dBV)	Multimeter-Full (dBV)	Dev (dB)		
-60	-60.36	-60.2	0.16		
-50	-50.19	-50.13	0.06		
-40	-40.14	-40.03	0.11		
-30	-30.13	-30.01	0.12		
-20	-20.12	-20	0.12		
-10	-10.14	-10	0.14		

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3. Measurement Test Setup

- a. Fine scan above the WD (TEM)
 - i. A multitone signal was applied to the handset such that the phone acoustic output was stable within 1dB over the probe settling time and with the acoustic output level at the C63.19 specified levels (below). The measurement step size was in 2 mm increments at a distance of 10 mm between the surface of the wireless device as shown below (note that in Figure 4-11, the grid is not to scale but merely a graphical representation of the coordinate system in use):



- ii. After scanning, the planar field maximum point was determined. The position of the probe was moved to this location to setup the test using the SoundCheck system.
- iii. These steps were repeated for all T-coil orientations (axial and radial) per Figure 4-13 after a T-coil orientation was fully measured with the SoundCheck system. b. Speech Signal Setup to Base Station Simulator
 - - i. C63.19 Table 7-1 states audio reference input levels for various technologies:

Standard	Technology	Input Level (dBm0)
TIA/EIA/IS-2000	CDMA	-18
J-STD-007	GSM (217)	-16
T1/T1P1/3GPP	UMTS (WCDMA)	-16
iDEN TM	TDMA (22 and 11 Hz)	-18

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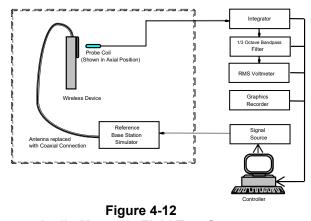
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- ii. See Section 5 for more information regarding audio level settings for Over-The-Top (OTT) Voice Over IP (VoIP) Testing.
- c. Real-Time Analyzer (RTA)
 - i. The Real-Time Analyzer was configured to analyze measurements using 1/3 Octave band weighted filtering.
- d. WD Radio Configuration Selection
 - i. The device was chosen to be tested in the worst-case ABM2 condition (NR configuration information can be found in Section 5.)
- 4. Signal Quality Data Analysis
 - a. Narrow-band Magnetic Intensity
 - i. The standard specifies a 1kHz 1/3 octave band minimum field intensity for a sine tone. The ABM1 measurements were evaluated at 1kHz with 1/3 octave band filtering over an averaged period of 10 seconds.
 - b. Frequency Response
 - i. The appropriate frequency response curve was measured to curves in Figure 3-1 or Figure 3-2 between 300 3000 Hz using digital linear averaging (limit lines chosen according to measurement found in step 4a). A linear average over 3x the length of the artificial voice signal (3x sampling) was performed. A 10 second delay was configured in the measurement process of the stimulus to ensure handset vocoder latency effects and echo cancellation devices (if any) were appropriately stabilized during measurements.
 - ii. The appropriate post-processing was applied according to the system processing chain illustrated in Figure 4-6. All R10 frequencies were plotted with respect to 0dB at 1kHz value and aligned with respect to the EIA-504 mask.
 - iii. The margin is represented by the closest measured data point on the curve to the EIA-504 limit lines, in dB.
 - c. Signal Quality Index
 - i. Ensuring the WD was at maximum RF power, maximum volume, backlight off, display on, maximum contrast setting, keypad lights on (when possible) with no audio signal through the vocoder, the WD was measured over at least 100 Hz 10,000 Hz, maximized over 5 seconds with a 50ms sample time for the ABM2 measurement (5 second time period is used in noise measurements under standards such as IEEE 269, etc.).
 - ii. After applying half-band integration and A-weighting to the result, a power sum was applied over each 1/3 octave bandwidth frequency for an ABM2 value.
 - iii. This result was subtracted from the ABM1 result in step a, to obtain the Signal Quality.

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V. Test Setup



Audio Magnetic Field Test Setup

Environmental conditions such as temperature and relative humidity are monitored to ensure there are no impacts on system specifications. Proper voltage and power line frequency conditions are maintained with three phase power sources. Environmental noise and reflections are monitored through system checks.

VI. Deviation from C63.19 Test Procedure

Non-conducted RF connection due to inaccessible RF ports.

VII. Air Interface Technologies Tested

All air interfaces which support voice capabilities over a managed CMRS or pre-installed OTT VoIP applications were tested for T-coil unless otherwise noted. See Table 2-1 for more details regarding which modes were tested.

VIII. Wireless Device Channels and Frequencies

1. 5G (NR) Modes

The bandwidth combination from each probe orientation resulting in the worst-case SNNR was additionally tested using low, low-mid, mid-high, and high channels for that band and bandwidth combination. See Table 6-2 for NR bandwidths and channels.

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IX. Test Flow

The flow diagram below was followed (From C63.19):

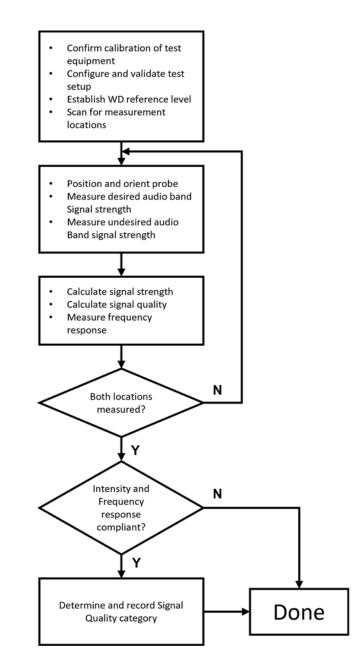


Figure 4-13 C63.19 T-Coil Signal Test Process

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5. OTT VOIP TEST SYSTEM AND DUT CONFIGURATION

I. Test System Setup for OTT VoIP T-Coil Testing

1. OTT VoIP Application

Google Duo is a pre-installed application on the DUT which allows for VoIP calls in a held-to-ear scenario. Duo uses the OPUS audio codec and supports a bitrate range of 6kb/s to 75kb/s. All air interfaces capable of a data connection were evaluated with Google Duo.

2. Equipment Setup

A CMW500 callbox was used to perform OTT VoIP T-coil measurements. The Data Application Unit (DAU) of the CMW500 was connected to the internet and allowed for an IP data connection on the DUT. An auxiliary VoIP unit was used to initiate an OTT VoIP call to the DUT. The auxiliary VoIP unit allowed for the configuration and monitoring of the OTT VoIP codec bitrate during a call. Both high and low bitrate settings were evaluated in to determine the worst-case configuration.

3. Audio Level Settings

According to KDB 285076 D02, the average speech level of -20dBm0 shall be used for protocols not specifically listed in Table 7.1 of ANSI C63.19-2011 or the ANSI C63.19-2011 VoLTE interpretation². The auxiliary VoIP unit allowed for monitoring the signal input level to ensure that the settings for speech input and full scale levels resulted in the -20dBm0 speech input level to the DUT for the OTT VoIP call.

Note: The green highlighted text is approved by FCC under the TCB PAG Re-Use Policy 388624 D01 IV. D. for T-Coil Testing for WI-FI calling and Google Duo.

II. DUT Configuration for OTT VoIP T-Coil Testing

1. Codec Configuration

An investigation was performed for each applicable data mode to determine the audio codec configuration to be used for testing. The effects of codec configuration were found to be independent of radio configuration; therefore, only one radio configuration for each applicable data mode was used for these investigations. The 6kbps codec setting was used for the audio codec on the auxiliary VoIP unit for OTT VoIP T-Coil testing. Please refer to the Original Certification Test Report (T-Coil report S/N: 1M2107290086-02.A3L) for full evaluation.

² FCC Office of Engineering and Technology KDB, "285076 D02 T-Coil Testing for CMRS IP v03," September 13, 2017

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2. Interim Procedure for evaluation OTT VoIP (NR)

The following procedure is used to evaluate OTT VoIP (NR) given equipment limitations.

- a. This procedure is applicable for OTT VoIP (NR) voice calls that use the same protocol, codec(s), and reference level as OTT VoIP (LTE) (i.e. -20dBm0).
- b. Establish the ABM1_{NR} value by using the ABM1_{LTE} magnetic intensity for an LTE call using a correlating LTE band through existing procedures and test equipment.
- c. Establish an ABM2_{NR} value using factory test mode (FTM) to simulate a NR connection for the desired NR band and channel under test.
- d. The following information is documented in Section 9:
 - i. $ABM2_{LTE}$ and $ABM2_{NR}$ for respective tests.
 - ii. Calculate SNNR:
 - 1. $ABM1 = ABM1_{LTE}$
 - 2. $ABM2 = ABM2_{NR}$
 - 3. $SNNR_{NR} = [ABM1_{LTE} ABM2_{NR}] 3dB$
 - a. A 3dB margin is built in to ensure conservative results with this interim procedure.

The above is only applicable for OTT VoIP scenarios, this device does not support VoNR over IMS.

The manufacturer has confirmed the handset as designed is expected to exhibit similar audio intensity levels between an OTT VoIP call placed over a 4G LTE and a 5G Sub-6GHz data connection.

3. Radio Configuration for OTT VoIP (NR)

An investigation was performed to determine the waveform, modulation, and RB configuration to be used for testing. Please see the original certification test report for more information. Due to equipment limitations, the procedure outlined in 5.II.2 was used to evaluate the SNNR for each radio configuration below. DFT-s-OFDM 16QAM, 1RB, 1RB offset was determined to be the worst-case configuration for the handset and will be used for full testing in Section 6.

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6. T-COIL TEST SUMMARY

	Consolidated Tabled Results										
			esponse rgin	Magnetic Intensity Verdict		FCC SNNR Verdict				Margin from FCC Limit	C63.19-2011
C62.10	9 Section	8.3.2		8.3.1		8.3.4		(dB)	Rating		
003.18	Section	Axial	Radial	Axial	Radial	Axial	Radial				
NR TDD (OTT VoIP)	n48	NA	NA	PASS	PASS	PASS	PASS	-17.82	Τ4		

Table 6-1

I. Raw Handset Data

Table 6-2 Raw Data Results for NR TDD n48 (OTT VoIP)

Mode	Orientation	Bandwidth	Channel	ABM1 _{LTE} [dB(A/m)]	ABM2 _{NR} [dB(A/m)]	ABM2 _{LTE} [dB(A/m)]	Ambient Noise [dB(A/m)]	Frequency Response Margin (dB)	S+N/N _{NR} (dB)	S+N/N _{NR} -3 dB (dB)	FCC Limit (dB)	Margin from FCC Limit (dB)	C63.19-2011 Rating	Test Coordinates				
		40MHz	645332	16.25	-27.47	-29.70		43.72	40.72	20.00	-20.72	T4						
		40MHz	643500	16.25	-28.25	-29.70		44.50	41.50	20.00	-21.50	T4						
		40MHz	641666	16.25	-27.08	-29.70			43.33	40.33	20.00	-20.33	T4					
	Axial	40MHz	639834	16.25	-28.01	-29.70	-58.41	N/A	44.26	41.26	20.00	-21.26	T4	1.8, 1.6				
		40MHz	638000	16.25	-28.16	-29.70							44.41	41.41	20.00	-21.41	T4	
		20MHz	641666	16.25	-28.80	-29.70				45.05	42.05	20.00	-22.05	T4				
NR n48		10MHz	641666	16.25	-29.37	-29.70					45.62	42.62	20.00	-22.62	T4			
1414 1140		40MHz	645332	8.00	-37.10	-32.08			45.10	42.10	20.00	-22.10	T4					
		40MHz	643500	8.00	-34.11	-32.08			42.11	39.11	20.00	-19.11	T4					
		40MHz	641666	8.00	-32.82	-32.08			40.82	37.82	20.00	-17.82	T4					
	Radial	40MHz	639834	8.00	-37.36	-32.08	-62.51	N/A	45.36	42.36	20.00	-22.36	T4	1.8, 2.2				
		40MHz	638000	8.00	-36.31	-32.08			44.31	41.31	20.00	-21.31	T4					
		20MHz	641666	8.00	-35.81	-32.08				43.81	40.81	20.00	-20.81	T4				
		10MHz	641666	8.00	-33.22	-32.08			41.22	38.22	20.00	-18.22	T4					

Table 6-3

Raw Data Results for LTE TDD B48 (OTT VoIP - Additional Measurements for NR)

												••••••			
Me	ode	Orientation	Bandwidth	Channel	ABM1 _{LTE} [dB(A/m)]	ABM2 _{NR} [dB(A/m)]	ABM2 _{LTE} [dB(A/m)]	Ambient Noise [dB(A/m)]	Frequency Response Margin (dB)	S+N/N _{LTE} (dB)	S+N/N _{NR} -3 dB (dB)	FCC Limit (dB)	Margin from FCC Limit (dB)	C63.19-2011 Rating	Test Coordinates
TER	and 48	Axial	20MHz	55990	16.25	N/A	-29.70	-58.41	N/A	45.95	N/A	20.00	-25.95	T4	1.8, 1.6
	anu 40	Radial	20MHz	55990	8.00	INA	-32.08	-62.51	INA	40.08	N/A	20.00	-20.08	T4	1.8, 2.2

II. Test Notes

A. General

- 1. Phone Condition: Mute on; Backlight off; Max Volume; Max Contrast
- 2. 'Radial' orientation refers to radial transverse.
- 3. Hearing Aid Mode (Phone > Call Settings > Other call settings > Hearing aid compatibility) was set to ON for Frequency Response compliance
- 4. Speech Signal: Mute on; Backlight off; Max Volume; Max Contrast
- 5. Bluetooth and WIFI were disabled while testing 5G modes.
- 6. The Margin from FCC limit column indicates a margin from the FCC limit for compliance (T4).

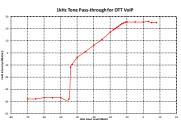
B. OTT VoIP

1. Vocoder Configuration: 6kbps

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- 2. NR TDD Configuration
 - a. Power Configuration: TxAGC is set such that the DUT operates at max power.
 - b. Radio Configuration: DFT-s-OFDM, 16QAM, 1RB, 1RB offset
 - c. Due to equipment limitations, ABM1 measurements were not possible. Therefore, the procedure outlined in Section 5.II.2 was followed to obtain SNNR values. Additionally, Frequency Response measurements were not possible due to equipment limitations.
 - d. The worst-case band and bandwidth combination for each probe orientation is additionally tested on the low and high channels for those combinations. NR n41 at 40MHz is the worst-case for the Axial and Radial probe orientations.

III. 1 kHz Vocoder Application Check



This model was verified to be within the linear region for ABM1 measurements at -20 dBm0 for OTT VoIP. This measurement was taken in the axial configuration above the maximum location.

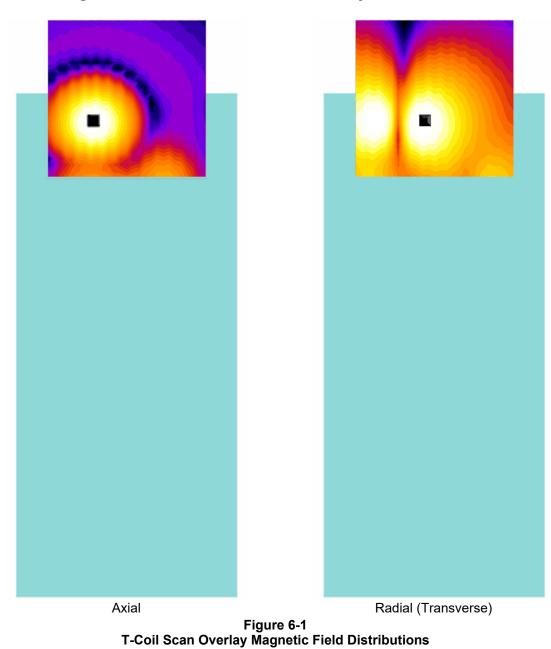
IV. T-Coil Validation Test Results

	Helimoliz Con Vermication Table of Results – 12/20/21								
ltem	Target	Result	Verdict						
Axial									
Magnetic Intensity, -10 dBA/m	-10 ± 0.5 dB	-9.848	PASS						
Environmental Noise	< -58 dBA/m	-58.41	PASS						
Frequency Response, from limits	> 0 dB	0.50	PASS						
Radial									
Magnetic Intensity, -10 dBA/m	-10 ± 0.5 dB	-10.316	PASS						
Environmental Noise	< -58 dBA/m	-62.51	PASS						
Frequency Response, from limits	> 0 dB	0.70	PASS						

Table 6-4Helmholtz Coil Verification Table of Results – 12/20/21

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V. ABM1 Magnetic Field Distribution Scan Overlays



Notes:

- 1. Final measurement locations are indicated by a cursor on the contour plots.
- 2. See Test Setup Photographs for actual WD overlay.

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7. MEASUREMENT UNCERTAINTY

Contribution	Data +/- %	Data +/- dB	Data Type	Probability distribution	Divisor	Standard uncertainty	Standard Uncertainty (dB)		
ABM Noise	7.0%	0.29	Std. Dev.	Normal k=1	1.00	7.0%			
RF Reflections	4.7%	0.20	Specification	Rectangular	1.73	2.7%			
Reference Signal Level	12.2%	0.50	Specification	Rectangular	1.73	7.0%			
Positioning Accuracy	10.0%	0.41	Uncertainty	Rectangular	1.73	5.8%			
Probe Coil Sensitivity	12.2%	0.50	Specification	Rectangular	1.73	7.0%			
Probe Linearity	2.4%	0.10	Std. Dev.	Normal k=1	1.00	2.4%			
Cable Loss	2.8%	0.12	Specification	Rectangular	1.73	1.6%			
Frequency Analyzer	5.0%	0.21	Specification	Rectangular	1.73	2.9%			
System Repeatability	5.0%	0.21	Std. Dev.	Normal k=1	1.00	5.0%			
WD Repeatability	9.0%	0.37	Std. Dev.	Normal k=1	1.00	9.0%			
Positioner Accuracy	1.0%	0.04	Specification	Rectangular	1.73	0.6%			
Combined standard uncertainty	Combined standard uncertainty, uc (k=1)								
Expanded uncertainty (k=2),	Expanded uncertainty (k=2), 95% confidence level								

Table 7-1 Uncertainty Estimation Table

Notes:

1. Test equipments are calibrated according to techniques outlined in NIS81, NIS3003 and NIST Tech Note 1297.

2. All equipments have traceability according to NIST. Measurement Uncertainties are defined in further detail in

NIS 81 and NIST Tech Note 1297 and UKAS M3003.

Measurement uncertainty reflects the quality and accuracy of a measured result as compared to the true value. Such statements are generally required when stating results of measurements so that it is clear to the intended audience that the results may differ when reproduced by different facilities. Measurement results vary due to the measurement uncertainty of the instrumentation, measurement technique, and test engineer. Most uncertainties are calculated using the tolerances of the instrumentation used in the measurement setup variability, and the technique used in performing the test. While not generally included, the variability of the equipment under test also figures into the overall measurement uncertainty. Another component of the overall uncertainty is based on the variability of repeated measurements (so-called Type A uncertainty). This may mean that the Hearing Aid compatibility tests may have to be repeated by taking down the test setup and resetting it up so that there are a statistically significant number of repeat measurements to identify the measurement uncertainty. By combining the repeat measurement results with that of the instrumentation chain using the technique contained in NIS 81 and NIS 3003, the overall measurement uncertainty was estimated.

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8. EQUIPMENT LIST

Table 8-1 Equipment List

Manufacturer	Model	Description	Cal Date	Cal Interval	Cal Due	Serial Number
Dell	Latitude E6540	SoundCheck Acoustic Analyzer Laptop	9/29/2020	Biennial	9/29/2022	2655082910
Listen	SoundConnect	Microphone Power Supply	9/24/2020	Biennial	9/24/2022	0899-PS150
RME	Fireface UC	undcheck Acoustic Analyzer External Audio Interfac	9/29/2020	Biennial	9/29/2022	23792992
Rohde & Schwarz	CMW500	Wideband Radio Communication Tester	2/10/2021	Annual	2/10/2022	161662
Rohde & Schwarz	CMW500	Wideband Radio Communication Tester	3/22/2021	Annual	3/22/2022	162125
Rohde & Schwarz	CMW 500	Radio Communication Tester	9/30/2021	Annual	9/30/2022	140144
Rohde & Schwarz	CMW 500	Radio Communication Tester	7/19/2021	Annual	7/19/2022	128635
Seekonk	NC-100	Torque Wrench (8" lb)	8/4/2020	Biennial	8/4/2022	21053
TEM	xial T-Coil Probe	Axial T-Coil Probe	9/23/2020	Biennial	9/23/2022	TEM-1123
TEM	adial T-Coil Prob	Radial T-Coil Probe	9/23/2020	Biennial	9/23/2022	TEM-1129
TEM		HAC Positioner	N/A		N/A	N/A
TEM		HAC System Controller with Software	N/A		N/A	N/A
TEM	Helmholtz Coil	Helmholtz Coil	9/23/2020	Biennial	9/23/2022	SBI 1052

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9. TEST DATA

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DUT: HH Coil – SN: SBI 1052 Type: HH Coil Serial: SBI 1052

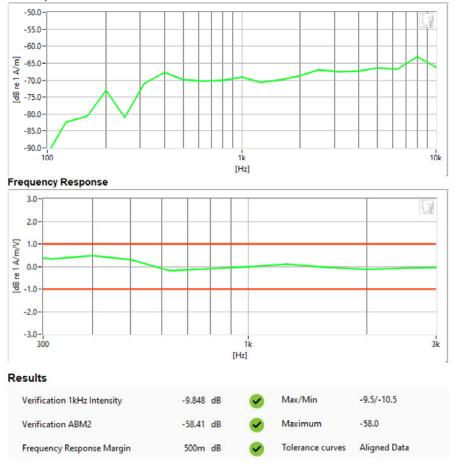
Measurement Standard: ANSI C63.19-2011

Equipment:

Probe: Axial T-Coil Probe – SN: TEM-1123; Calibrated: 9/23/2020

Helmholtz Coil – SN: SBI 1052; Calibrated: 9/23/2020

Noise Spectrum



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DUT: HH Coil – SN: SBI 1052 Type: HH Coil Serial: SBI 1052

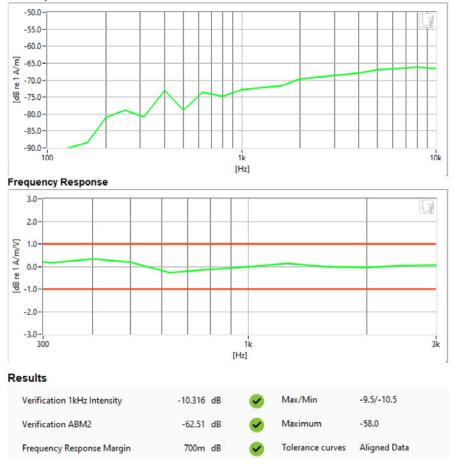
Measurement Standard: ANSI C63.19-2011

Equipment:

Probe: Radial T-Coil Probe – SN: TEM-1129; Calibrated: 9/23/2020

Helmholtz Coil – SN: SBI 1052; Calibrated: 9/23/2020

Noise Spectrum



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DUT: A3LSMF711U1 Type: Portable Handset Serial: 0908M

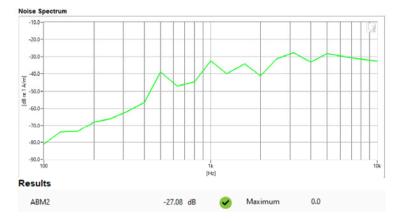
Measurement Standard: ANSI C63.19-2011

Equipment:

Probe: Axial T-Coil Probe – SN: TEM-1123; Calibrated: 9/23/2020

Test Configuration:

- VoIP Application: Google Duo
- Mode: NR TDD n48
- · Bandwidth: 40MHz
- Channel: 641666



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DUT: A3LSMF711U1 Type: Portable Handset Serial: 0908M

Measurement Standard: ANSI C63.19-2011

Equipment:

Probe: Radial T-Coil Probe – SN: TEM-1129; Calibrated: 9/23/2020

Test Configuration:

- VolP Application: Google Duo
- Mode: NR TDD n48
- · Bandwidth: 40MHz
- Channel: 641666



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10. CALIBRATION CERTIFICATES

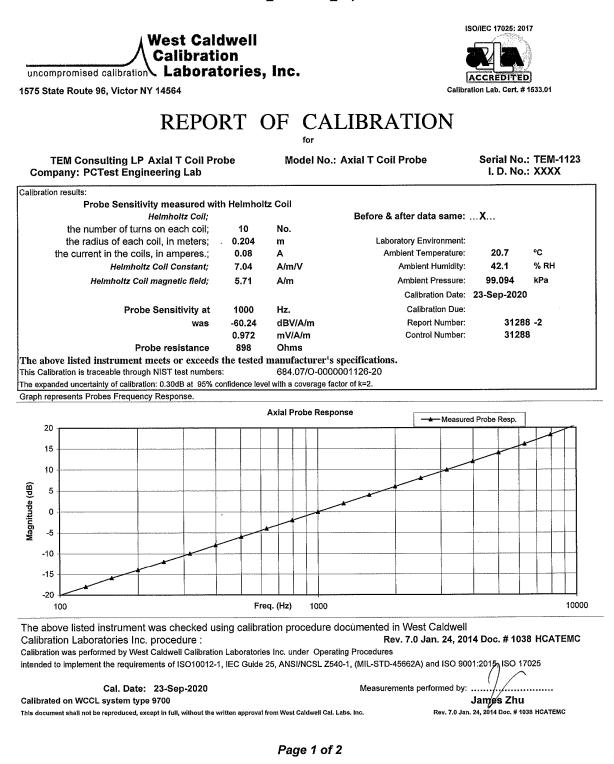
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	West	Caldwell C	alibration L	aboratories	Inc.	
	Certif	ficate	of Cor	nform	ance	
			for			1000
		AX Manufactured Model No: Serial No: Calibration Red	AXIAL TEM-11	DNSULTING F COIL PROBE 23		
			Submitted By:			1.5
		Customer:	ANDREW HARW	ELL		1. and the second
		Company: Address:	PCTEST ENGINE 6660-B DOBBIN R COLUMBIA	ERING LAB OAD	21045	
	SI through the Natior	nal Institute of Stand his document certifi hitter.	the indicated specific dards and Technology es that the instrument Procedure No.	or to accepted value	es of natural	0.333
	Upon receipt for Cali				10/13/2020	11.
	Within		fent was found to be.		· · · · · · · ·	
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	Note: With this Certificate,	Report of Calibration i	s included.	Approved by:	1	
	Calibration Date:	23-Sep-20		James 2	Chu/	
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FCC ID: A3LSMF711U1	PCTEST Novel to be part of @ internet	HAC (T-COIL) TEST REPORT	SAMSUNG	Approved by: Quality Manager
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West Caldwell Calibration Laboratories Inc.

1575 State Route 96, Victor NY 14564 Tel. (585) 586-3900 FAX (585) 586-4327

Calibration Data Record

TEM Consulting LP Axial T Coil Probe Company: PCTest Engineering Lab ^{for} Model No.: Axial T Coil Probe

Serial No.: TEM-1123

Test	Function	Tolerance		Measured values		
				Before	Out	Remarks
1.0	Probe Sensitivity at	1000 Hz.	dBV/A/m	-60.24		
			dB			
2.0	Probe Level Linearity		6	6.03		
		Ref. (0 dB)	0	0.00		
			-6	-6.03		
			-12	-12.05		
			Hz			
3.0	Probe Frequency Response		100	-20.0		
			126	-18.0		1
			158	-15.9		
			200	-14.0		
			251	-12.0		
			316	-10.0		
			398	-8.0		
			501	-6.0		
			631	-4.0		
			794	-2.0		
		Ref. (0 dB)	1000	0.0		
			1259	2.0		
			1585	4.0		
			1995	6.0		
			2512	8.0		
			3162	10.0		
			3981	12.0		
			5012	14.0		
		6310	16.1			
			7943	18.3		
			10000	20.7		

Instruments u	sed for calibration:		Date of Cal.	Traceablity No.	Due Date
HP	34401A	S/N US360641	2-Jul-2020	,610119	2-Jul-2021
HP	34401A	S/N US361024	2-Jul-2020	.610119	2-Jul-2021
HP	33120A	S/N US360437	2-Jul-2020	,610119	2-Jul-2021
B&K	2133	S/N 1583254	1-Jul-2020	684.07/O-0000001126-20	1-Jul-2021

Cal. Date: 23-Sep-2020

Tested by: James Zhu

Calibrated on WCCL system type 9700

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8/18/2020

	West Caldwell C	alibratio	n Laboratoi	ries Inc.
	Certificate	of C	onfor	mance
		for		
	RAI Manufactured Model No: Serial No: Calibration Re	F J	PROBE 'EM CONSULTING ADIAL T COIL PRC 'EM-1129 1288	BE
		Submitted B	/:	
	Customer:	ANDREW	HARWELL	
	Company: Address:		NGINEERING LAB BBIN ROAD A	MD 21045
	SI through the National Institute of Stan physical constants. This document certif its return to the submitter. West Caldwell Calibration Laboratories	ies that the inst	rument met the follow	ing specification upon
	Upon receipt for Calibration, the instru	ment was found	to be:	19/13/2020
	Within (X)			
	tolerance of the indicated specification. S The information supplied relates to the of for ALL given specifications and standar acceptance limit, L is manufacturer spec includes but not limited to:1. Measured 2.Manufacturer's tolerance is too small uncertainties, 3. Test uncertainty ratio d limitations. The decision rule has been co	calibrated item rds fall under t cifications and b value does not compared to ca loes not meet th ommunicated a	listed above and statm he decision rule: A=(L J95 is confidence level neet manufacturer's t libration and measurr e 4:1 ratio due to test nd approved by custo	-(U95)), where A is of 95% at k=2. This olerance, nent capability instrumentation mer during contract
	West Caldwell Calibration Laboratories requirements, ISO 10012-1 MIL STD 45 and ISO 17025	' calibration co 662A, ANSI/N	ntrol system meets the CSL Z540-1, IEC Guid	e following le 25, ISO 9001:2015,
	Note: With this Certificate, Report of Calibration	is included.	Approved l	oy:
	Calibration Date: 23-Sep-20		J	ames Zhu
	Certificate No: 31288 - 1		-	ity Manager
y i		ertificate Page 1		C 17025:2017
	West Caldwel Calibration Compromised calibration 75 State Route 96, Victor, NY 14564, U.S.A.	-		CREDITED Lab. Cert. # 1533.01

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HCRTEMC_TEM-1129_Sep-23-2020



1575 State Route 96, Victor NY 14564



REPORT OF CALIBRATION

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ap	20 15	ded i	uncerta	inty of ca	libratio	on: 0.30	dB at	95% o			684 el with a	.07/O a cover	-00000 age facl	001126- or of k=2				Measure	ed Probe	Resp.		
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Calibrated on WCCL system type 9700

James Zhu

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West Caldwell Calibration Laboratories Inc.

1575 State Route 96, Victor NY 14564 Tel. (585) 586-3900 FAX (585) 586-4327

Calibration Data Record

TEM Consulting LP Radial T Coil Probe Company: PCTest Engineering Lab ^{for} Model No.: Radial T Coil Probe

Serial No.: TEM-1129

Test	Function	Tolera	nce	Me	asured val	ues
			····.	Before	Out	Remarks
1.0	Probe Sensitivity at	1000 Hz.	dBV/A/m	-60.37		
			dB			
2.0	Probe Level Linearity		6	6.04		
		Ref. (0 dB)	0	0.00		
			-6	-6.03		
			-12	-12.05		
			Hz			
3.0	Probe Frequency Response		100	-20.0		
			126	-18.0		
			158	-16.0		
			200	-14.0		
			251	-12.0		
			316	-10.0		
			398	-8.0		
			501	-6.0		
			631	-4.0		
			794	-2.0		
		Ref. (0 dB)	1000	0.0		
			1259	2.0		
			1585	4.0		
			1995	6.0		
			2512	8.0		
			3162	10.0		
			3981	12.0		
			5012	14.0		
			6310	16.1		
			7943	18.3		
			10000	20.7		

Instrument	is used for calibration:		Date of Cal.	Traceability No.	Due Date
HP	34401A	S/N US360641	2-Jul-2020	,610119	2-Jul-2021
HP	34401A	S/N US361024	2-Jul-2020	,610119	2-Jul-2021
НР	33120A	S/N US360437	2-Jul-2020	.610119	2-Jul-2021
B&K	2133	S/N 1583254	1-Jul-2020	684.07/O-0000001126-20	1-Jul-2021

Cal. Date: 23-Sep-2020 Calibrated on WCCL system type 9700

Tested by: James Zhu

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11. CONCLUSION

The measurements indicate that the NR TDD n48 mode of the referenced wireless communications device complies with the HAC limits specified in accordance with the ANSI C63.19 Standard and FCC WT Docket No. 01-309 RM-8658. Precise laboratory measures were taken to assure repeatability of the tests. The tested device complies with the requirements in respect to all parameters specific to the test. The test results and statements relate only to the item(s) tested.

The measurement system and techniques presented in this evaluation are proposed in the ANSI standard as a means of best approximating wireless device compatibility with a hearing-aid. The literature is under continual re-construction.

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12. **REFERENCES**

- 1. ANSI C63.19-2011, American National Standard for Methods of Measurement of Compatibility between Wireless communication devices and Hearing Aids.", New York, NY, IEEE, May 2011
- FCC Office of Engineering and Technology KDB, "285076 D01 HAC Guidance v05," September 13, 2017
- FCC Office of Engineering and Technology KDB, "285076 D02 T-Coil Testing for CMRS IP v03," September 13, 2017
- 4. FCC Public Notice DA 06-1215, Wireless Telecommunications Bureau and Office of Engineering and Technology Clarify Use of Revised Wireless Phone Hearing Aid Compatibility Standard, June 6, 2006
- 5. FCC 3G Review Guidance, Laboratory Division OET FCC, May/June 2006
- Berger, H. S., "Compatibility Between Hearing Aids and Wireless Devices," Electronic Industries Forum, Boston, MA, May, 1997
- 7. Berger, H. S., "Hearing Aid and Cellular Phone Compatibility: Working Toward Solutions," Wireless Telephones and Hearing Aids: New Challenges for Audiology, Gallaudet University, Washington, D.C., May, 1997 (To be reprinted in the American Journal of Audiology).
- 8. Berger, H. S., "Hearing Aid Compatibility with Wireless Communications Devices, " IEEE International Symposium on Electromagnetic Compatibility, Austin, TX, August, 1997.
- Bronaugh, E. L., "Simplifying EMI Immunity (Susceptibility) Tests in TEM Cells," in the 1990 IEEE International Symposium on Electromagnetic Compatibility Symposium Record, Washington, D.C., August 1990, pp. 488-491
- 10. Byme, D. and Dillon, H., The National Acoustics Laboratory (NAL) New Procedure for Selecting the Gain and Frequency Response of a Hearing Aid, Ear and Hearing 7:257-265, 1986.
- Crawford, M. L., "Measurement of Electromagnetic Radiation from Electronic Equipment using TEM Transmission Cells, " U.S. Department of Commerce, National Bureau of Standards, NBSIR 73-306, Feb. 1973.
- Crawford, M. L., and Workman, J. L., "Using a TEM Cell for EMC Measurements of Electronic Equipment," U.S. Department of Commerce, National Bureau of Standards. Technical Note 1013, July 1981.
- 13. EHIMA GSM Project, Development phase, Project Report (1st part) Revision A. Technical-Audiological Laboratory and Telecom Denmark, October 1993.
- 14. EHIMA GSM Project, Development phase, Part II Project Report. Technical-Audiological Laboratory and Telecom Denmark, June 1994.
- EHIMA GSM Project Final Report, Hearing Aids and GSM Mobile Telephones: Interference Problems, Methods of Measurement and Levels of Immunity. Technical-Audiological Laboratory and Telecom Denmark, 1995.
- 16. HAMPIS Report, Comparison of Mobile phone electromagnetic near field with an upscaled electromagnetic far field, using hearing aid as reference, 21 October 1999.

FCC ID: A3LSMF711U1	Portest Prod to be pert of @ interned	HAC (T-COIL) TEST REPORT	SAMSUNG	Approved by: Quality Manager
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© 2022 PCTEST		·		REV 3.5.M

- 17. Hearing Aids/GSM, Report from OTWIDAM, Technical-Audiological Laboratory and Telecom Denmark, April 1993.
- 18. IEEE 100, The Authoritative Dictionary of IEEE Standards Terms, Seventh Edition.
- Joyner, K. H, et. al., Interference to Hearing Aids by the New Digital Mobile Telephone System, Global System for Mobile (GSM) Communication Standard, National Acoustic Laboratory, Australian Hearing Series, Sydney 1993.
- Joyner, K. H., et. al., Interference to Hearing Aids by the Digital Mobile Telephone System, Global System for Mobile Communications (GSM), NAL Report #131, National Acoustic Laboratory, Australian Hearing Series, Sydney, 1995.
- 21. Kecker, W. T., Crawford, M. L., and Wilson, W. A., "Contruction of a Transverse Electromagnetic Cell", U.S. Department of Commerce, National Bureau of Standards, Technical Note 1011, Nov. 1978.
- 22. Konigstein, D., and Hansen, D., "A New Family of TEM Cells with enlarged bandwidth and Optimized working Volume," in the Proceedings of the 7th International Symposium on EMC, Zurich, Switzerland, March 1987; 50:9, pp. 127-132.
- 23. Kuk, F., and Hjorstgaard, N. K., "Factors affecting interference from digital cellular telephones," Hearing Journal, 1997; 50:9, pp 32-34.
- 24. Ma, M. A., and Kanda, M., "Electromagnetic Compatibility and Interference Metrology," U.S. Department of Commerce, National Bureau of Standards, Technical Note 1099, July 1986, pp. 17-43.
- Ma, M. A., Sreenivashiah, I., and Chang, D. C., "A Method of Determining the Emission and Susceptibility Levels of Electrically Small Objects Using a TEM Cell," U.S. Department of Commerce, National Bureau of Standards, Technial Note 1040, July 1981.
- 26. McCandless, G. A., and Lyregaard, P. E., Prescription of Gain/Output (POGO) for Hearing Aids, Hearing Instruments 1:16-21, 1983
- 27. Skopec, M., "Hearing Aid Electromagnetic Interference from Digital Wireless Telephones, "IEEE Transactions on Rehabilitation Engineering, vol. 6, no. 2, pp. 235-239, June 1998.
- 28. Technical Report, GSM 05.90, GSM EMC Considerations, European Telecommunications Standards Institute, January 1993.
- Victorian, T. A., "Digital Cellular Telephone Interference and Hearing Aid Compatibility—an Update," Hearing Journal 1998; 51:10, pp. 53-60
- 30. Wong, G. S. K., and Embleton, T. F. W., eds., AIP Handbook of Condenser Microphones: Theory, Calibration and Measurements, AIP Press.

FCC ID: A3LSMF711U1	PCTEST: Proud to be part of @ internet	HAC (T-COIL) TEST REPORT	SAMSUNG	Approved by: Quality Manager
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